


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583029	<b>Applicant(s)/Patent Under Reexamination</b>  TAKEDA ET AL.
	<b>Examiner</b>  KAIYEU CHU	<b>Art Unit</b>  3771

SEARCHED			
Class	Subclass	Date	Examiner
128	200.24, 201.13, 203.12, 203.16, 203.17, 203.26, 203.27, 204.17	2/18/2010	KC
261	104	2/18/2010	KC
	Updated Above Search	8/25/2010	KC

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search (No Assignee)	2/4/2010	KC
See attached EAST Search History	2/18/2010	KC
Consulted Annette Dixon	2/4/2010	KC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/KAIYEU CHU/  
Examiner, Art Unit 3771